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QA3118M6N

30V Asymmetric Dual N-Channel Power MOSFET

General Description

The QA3118M6N is a high performance trench Dual N-channel asymmetric MOSFET which utilizes extremely high cell density to provide low $R_{DS(on)}$ and gate charge characteristics. It is ideally suited to support synchronous buck converter applications.

The QA3118M6N meets RoHS and Green Product requirements while supporting full function reliability.

Features

- ✓ Advanced high cell density Trench technology
- ✓ Super Low Gate Charge
- ✓ Excellent CdV/dt effect decline
- ✓ Green Device Available

Product Summary

	V_{DS}	$R_{DS(ON)\ max}$ ($V_{GS}=10V$)	I_D ($T_c=25\ ^\circ C$)
Die1	30V	5.0mΩ	63A
Die2	30V	1.9mΩ	115A

Applications

- ✓ High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- ✓ Networking DC-DC Power System
- ✓ CCFL Back-light Inverter

Pin Configuration



Ordering Information

Order Number	Package Type	Top Marking
QA3118M6N	PRPAK5X6	

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Absolute Maximum Ratings

Symbol	Parameter	Rating		Units
		Die1	Die2	
V _{DS}	Drain-Source Voltage	30	30	V
V _{GS}	Gate-Source Voltage	±20	±12	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	63	115	A
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	40	73	A
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	16	28	A
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	13	22	A
I _{DM}	Pulsed Drain Current ²	126	230	A
EAS	Single Pulse Avalanche Energy ³	60.2	250.6	mJ
I _{AS}	Avalanche Current	34.7	70.8	A
P _D @T _C =25°C	Total Power Dissipation ⁴	31	37	W
P _{DSM} @T _A =25°C	Total Power Dissipation ⁴	2	2.2	W
T _{STG}	Storage Temperature Range	-55 to 150	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C

Thermal Data

Symbol	Parameter	Die1	Die2	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹	62	56	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹	4	3.3	°C/W

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Die1 N-Channel Electrical Characteristics

Die1 N-Channel Electrical Characteristics: ($T_J=25\text{ }^{\circ}\text{C}$, unless otherwise noted)						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	30	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	BVDSS Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	--	0.017	--	$\text{V}/^{\circ}\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=10\text{V}, I_D=30\text{A}$	--	4.0	5.0	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=15\text{A}$	--	5.7	7.4	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D = 250\mu\text{A}$	1.2	--	2.5	V
$\Delta V_{GS(th)} / \Delta T_J$	$V_{GS(th)}$ Temperature Coefficient		--	-4.1	--	$\text{mV}/^{\circ}\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$	--	--	1	uA
		$V_{DS}=24\text{V}, V_{GS}=0\text{V}, T_J=55^{\circ}\text{C}$	--	--	5	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	--	--	± 100	nA
g_{fs}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=15\text{A}$	--	27	--	S
R_g	Gate Resistance	$V_{DS}=0\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	1.7	--	Ω
Q_g	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_D=15\text{A}$	--	14.5	--	nC
Q_g	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=4.5\text{V}, I_D=15\text{A}$	--	6.9	--	nC
Q_{gs}	Gate-Source Charge		--	2.8	--	
Q_{gd}	Gate-Drain Charge		--	2.2	--	
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, R_G=3.3\Omega,$ $I_D=15\text{A}$	--	6.2	--	ns
t_r	Rise Time		--	43.3	--	
$t_{d(off)}$	Turn-Off Delay Time		--	15.5	--	
t_f	Fall Time		--	2.5	--	
C_{iss}	Input Capacitance	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	861	--	pF
C_{oss}	Output Capacitance		--	287	--	
C_{rss}	Reverse Transfer Capacitance		--	22	--	

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Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	$V_{DD}=25V$, $L=0.1mH$, $I_{AS}=25A$	31.25	--	--	mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Source Current ^{1,6}	$V_G=V_D=0V$, Force Current	--	--	63	A
I_{SM}	Pulsed Source Current ^{2,6}		--	--	126	A
V_{SD}	Diode Forward Voltage ²	$V_{GS}=0V$, $I_S=1A$, $T_J=25^\circ C$	--	--	1.2	V
t_{rr}	Reverse Recovery Time	$I_F=15A$, $dI/dt=100A/\mu s$, $T_J=25^\circ C$	--	19	--	nS
Q_{rr}	Reverse Recovery Charge		--	7	--	nC

Note:

1. Test data conducted with surface mount attachment to 1 inch², FR-4 board utilizing 2oz copper
2. Pulse Test. Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. EAS data is a maximum rating. The test condition is $V_{DD}=25V$, $V_{GS}=10V$, $L=0.1mH$
4. The power dissipation is limited by a $150^\circ C$ maximum junction temperature
5. The Min. value is 100% EAS tested guarantee
6. The data is theoretically the same as I_D and I_{DM} . In real applications, it will be limited by total power

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Die2 N-Channel Electrical Characteristics

Die2 N-Channel Electrical Characteristics: ($T_J=25\text{ }^{\circ}\text{C}$, unless otherwise noted)						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	30	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	BVDSS Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	--	0.015	--	$\text{V}/^{\circ}\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=10\text{V}, I_D=30\text{A}$	--	1.5	1.9	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=15\text{A}$	--	1.9	2.5	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D = 250\mu\text{A}$	1.2	--	2.5	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		--	-4.2	--	$\text{mV}/^{\circ}\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$	--	--	1	uA
		$V_{DS}=24\text{V}, V_{GS}=0\text{V}, T_J=55^{\circ}\text{C}$	--	--	5	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 12\text{V}, V_{DS}=0\text{V}$	--	--	± 100	nA
g_{fs}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=15\text{A}$	--	41	--	S
R_g	Gate Resistance	$V_{DS}=0\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	1.0	--	Ω
Q_g	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_D=15\text{A}$	--	55.1	--	nC
Q_g	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=4.5\text{V}, I_D=15\text{A}$	--	24.5	--	nC
Q_{gs}	Gate-Source Charge		--	10.8	--	
Q_{gd}	Gate-Drain Charge		--	4.7	--	
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, R_G=3.3\Omega, I_D=15\text{A}$	--	11.3	--	ns
t_r	Rise Time		--	44.3	--	
$t_{d(off)}$	Turn-Off Delay Time		--	41.6	--	
t_f	Fall Time		--	6.2	--	
C_{iss}	Input Capacitance	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	3738	--	pF
C_{oss}	Output Capacitance		--	933	--	
C_{rss}	Reverse Transfer Capacitance		--	46	--	

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Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	$V_{DD}=25V$, $L=0.1mH$, $I_{AS}=51A$	130.05	--	--	mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Source Current ^{1,6}	$V_G=V_D=0V$, Force Current	--	--	115	A
I_{SM}	Pulsed Source Current ^{2,6}		--	--	230	A
V_{SD}	Diode Forward Voltage ²	$V_{GS}=0V$, $I_S=1A$, $T_J=25^\circ C$	--	--	1.2	V
t_{rr}	Reverse Recovery Time	$I_F=15A$, $di/dt=100A/\mu s$, $T_J=25^\circ C$	--	38	--	nS
Q_{rr}	Reverse Recovery Charge		--	32	--	nC

Note:

1. Test data conducted with surface mount attachment to 1 inch², FR-4 board utilizing 2oz copper
2. Pulse Test. Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. EAS data is a maximum rating. The test condition is $V_{DD}=25V$, $V_{GS}=10V$, $L=0.1mH$
4. The power dissipation is limited by a $150^\circ C$ maximum junction temperature
5. The Min. value is 100% EAS tested guaranteee
6. The data is theoretically the same as I_D and I_{DM} . In real applications, it will be limited by total power

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Die1 Typical Characteristics

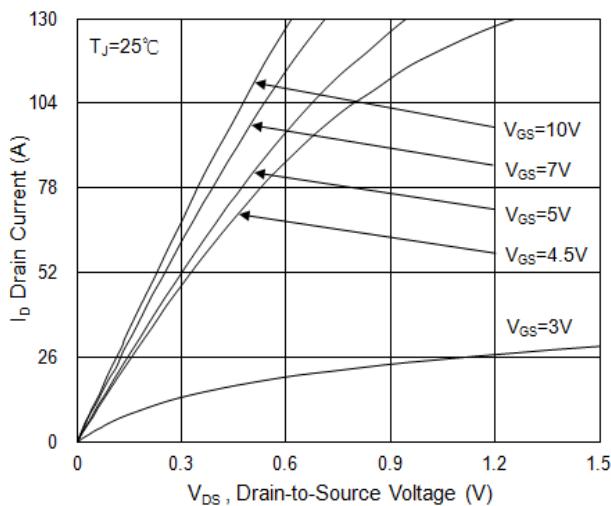


Fig.1: Typical Output Characteristics

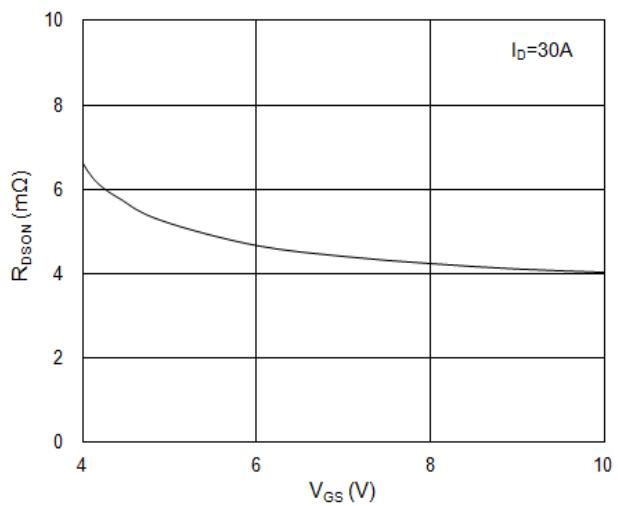


Fig.2: On-Resistance vs. Gate-Source

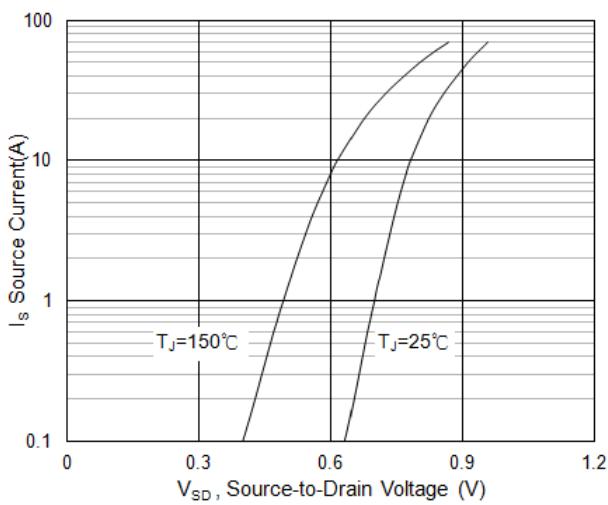


Fig.3: Forward Characteristics of Reverse

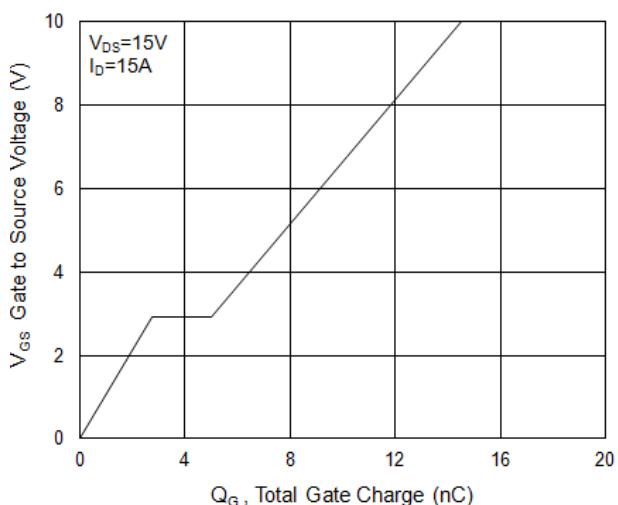


Fig.4: Gate-Charge Characteristics

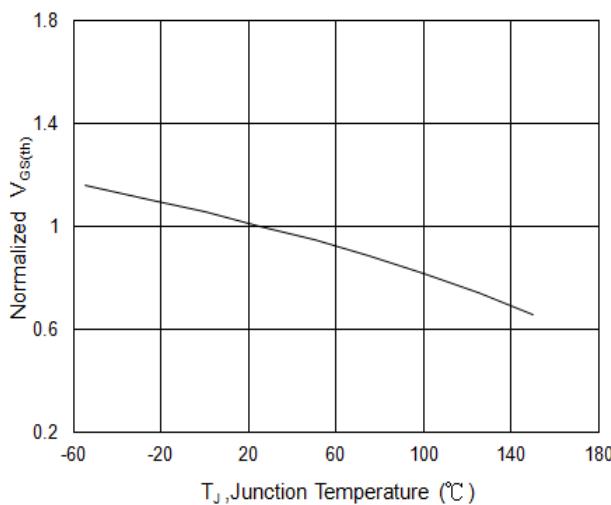


Fig.5: Normalized $V_{GS(th)}$ vs. T_J

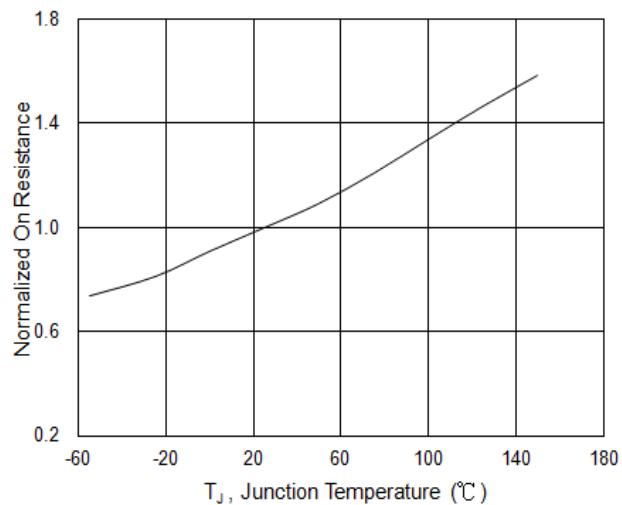


Fig.6: Normalized $R_{DS(on)}$ vs. T_J

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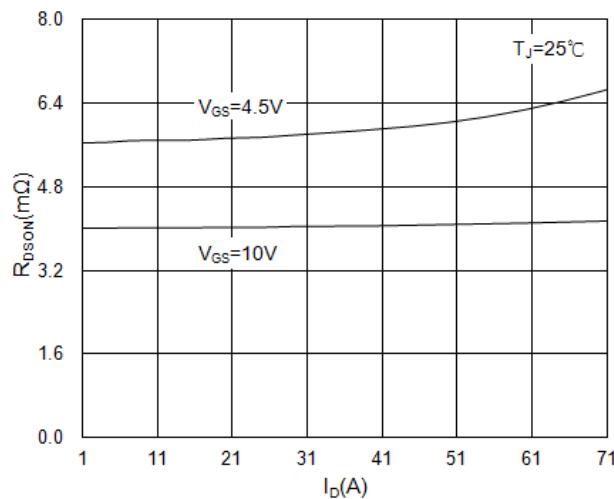


Fig.7: Drain-Source On-State Resistance

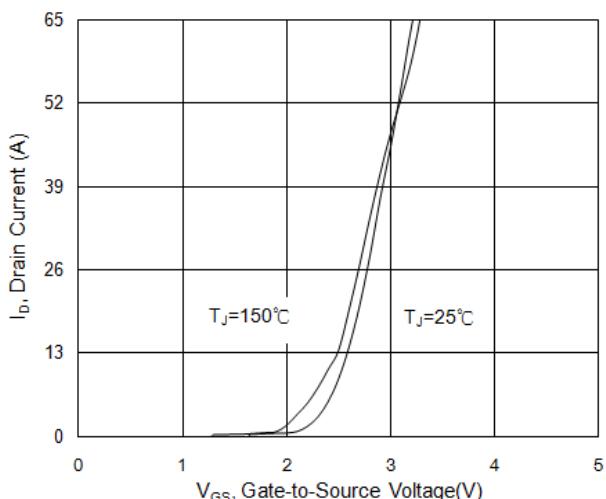


Fig.8: Transfer Characteristics

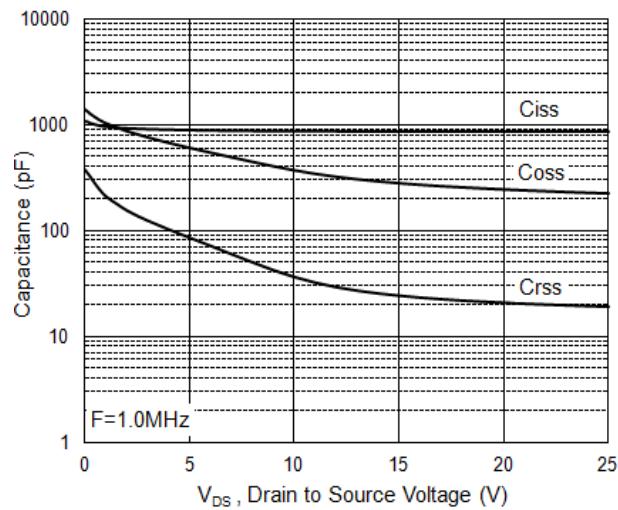


Fig.9: Capacitance

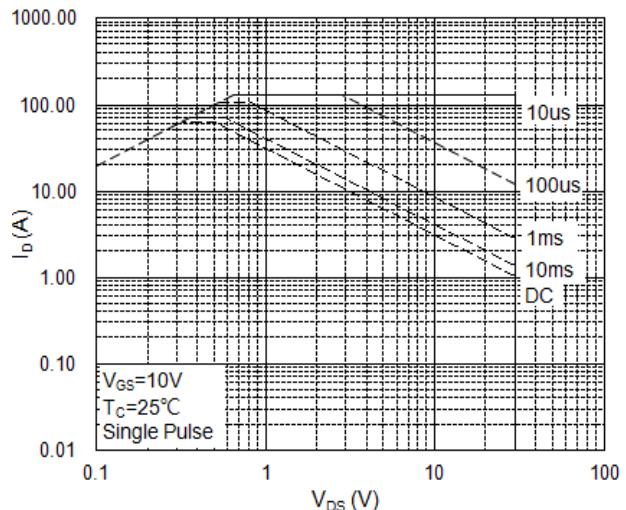


Fig.10: Safe Operating Area

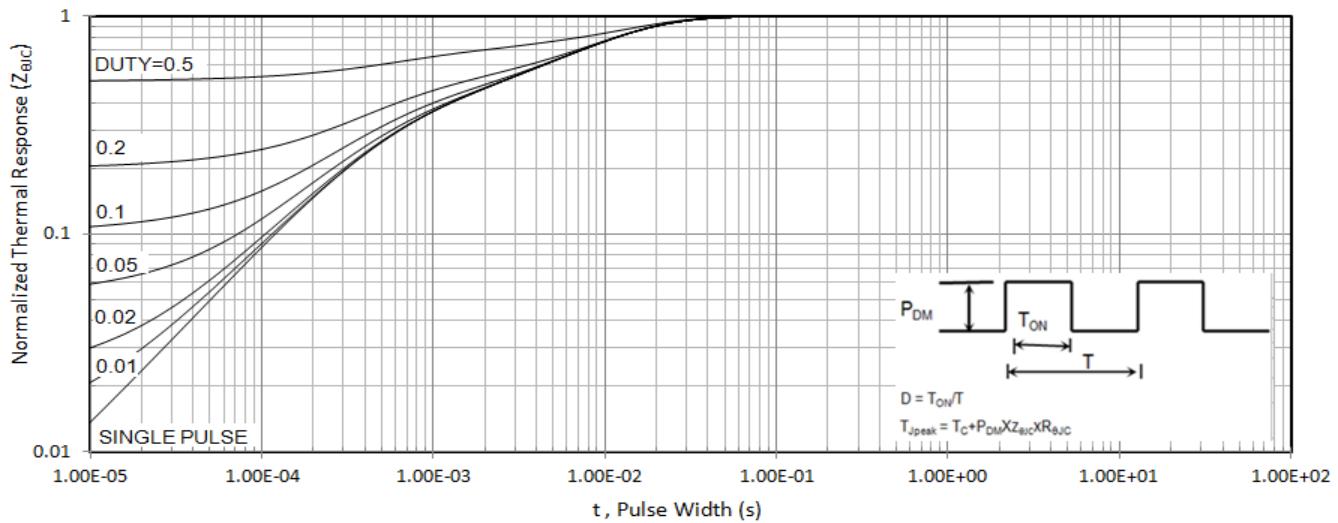


Fig.11: Transient Thermal Impedance

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Die2 Typical Characteristics

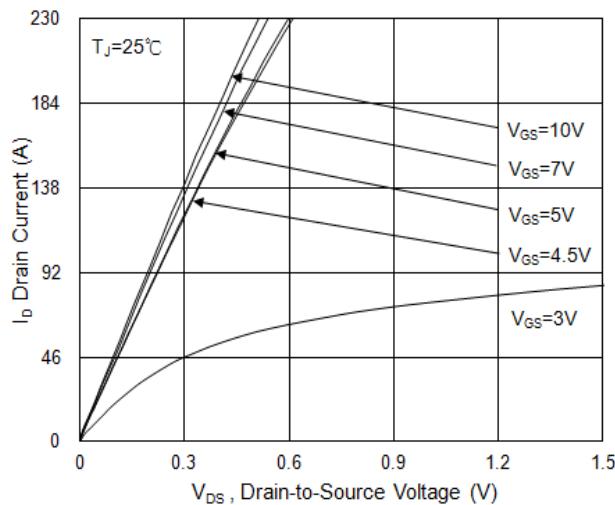


Fig.1: Typical Output Characteristics

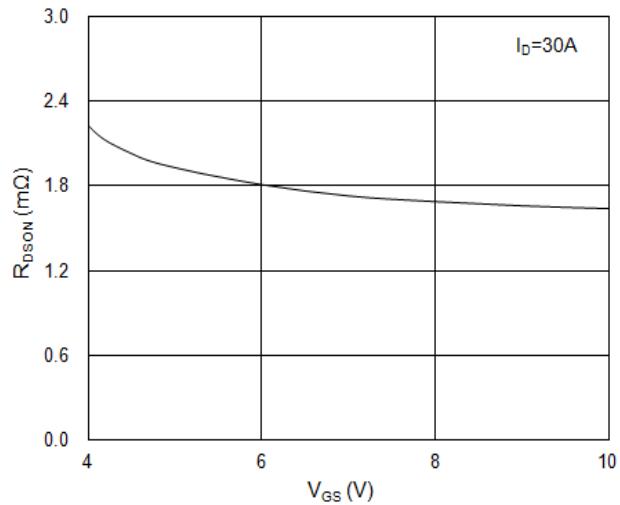


Fig.2: On-Resistance vs. Gate-Source

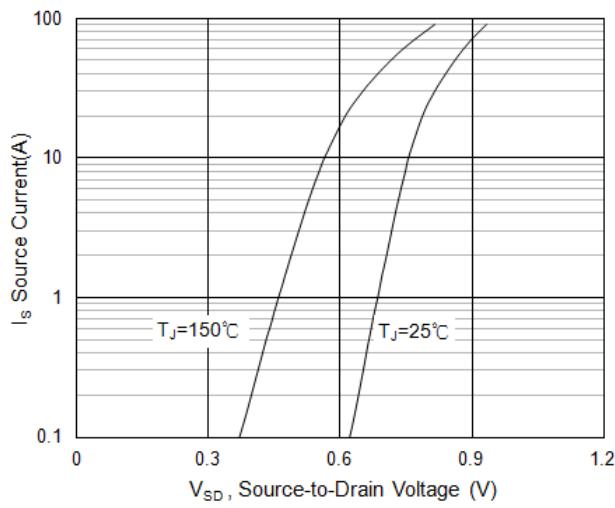


Fig.3: Forward Characteristics of Reverse

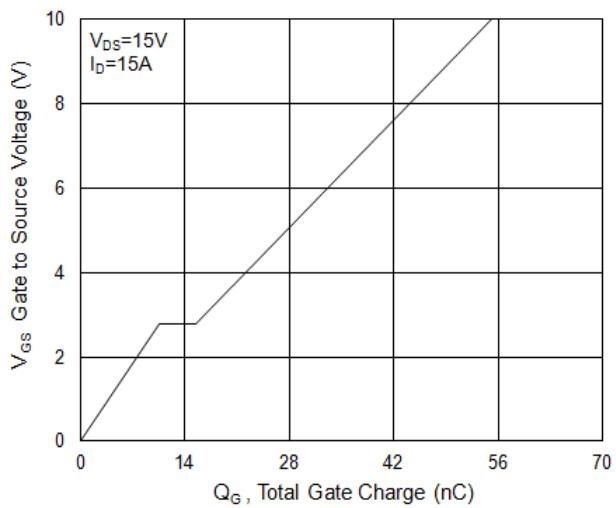


Fig.4: Gate-Charge Characteristics

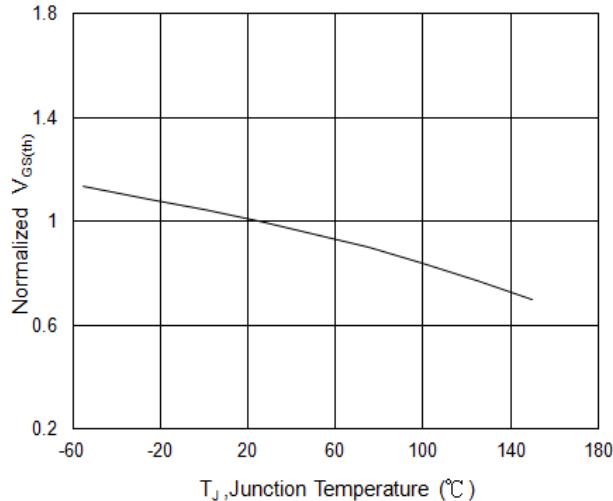


Fig.5: Normalized $V_{GS(th)}$ vs. T_J

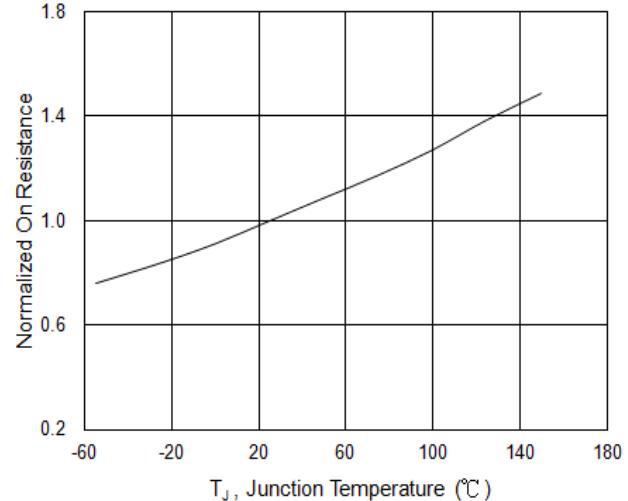


Fig.6: Normalized $R_{DS(on)}$ vs. T_J

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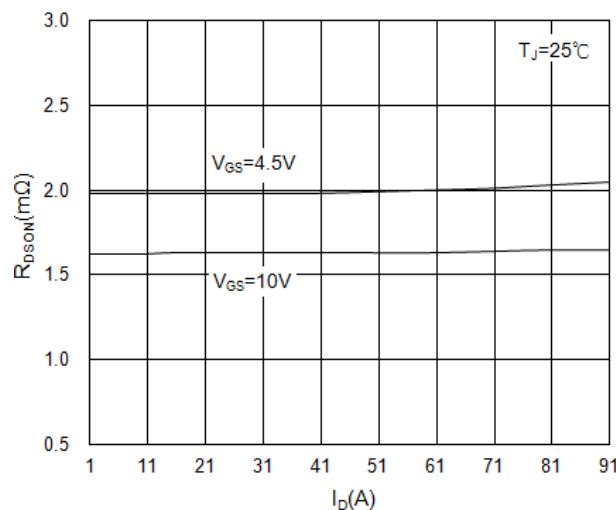


Fig.7: Drain-Source On-State Resistance

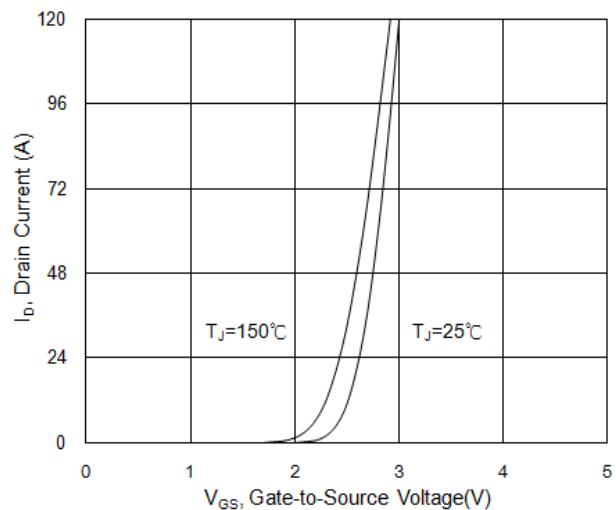


Fig.8: Transfer Characteristics

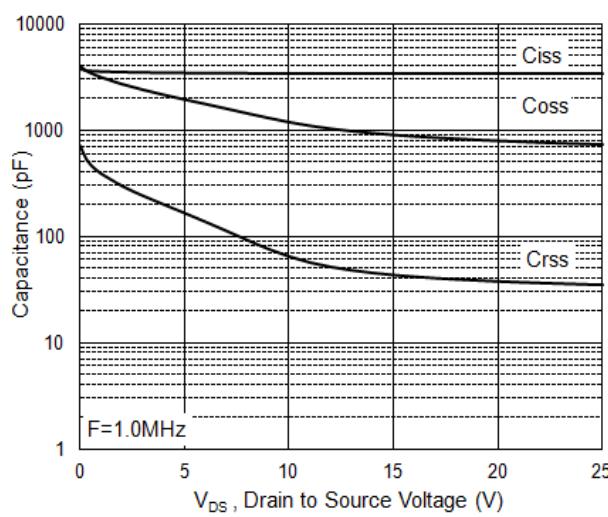


Fig.9: Capacitance

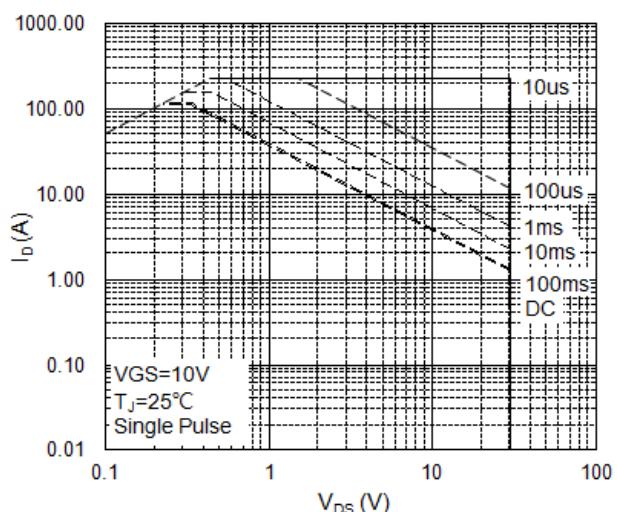


Fig.10: Safe Operating Area

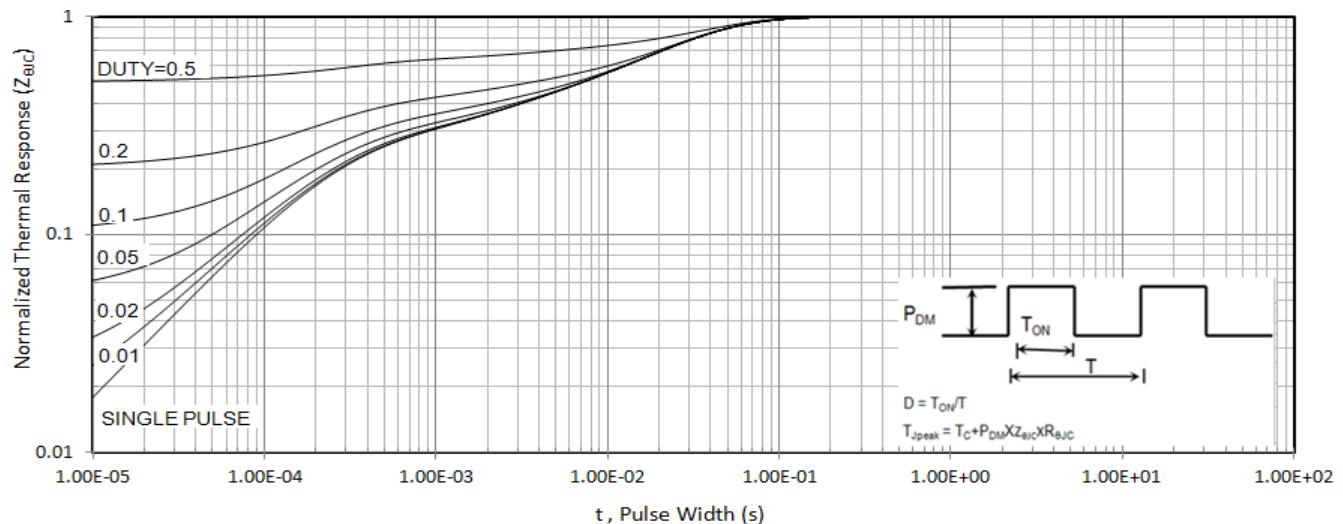


Fig.11: Transient Thermal Impedance

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uPI Semiconductor Corp.

9F., No.5, Taiyuan 1st St. Zhubei City, Hsinchu, Taiwan, R.O.C.

TEL : 886.3.560.1666 FAX : 886.3.560.1888